

AOB256L

150V N-Channel MOSFET

General Description

The AOB256L uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$, Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

 V_{DS} 150V I_D (at $V_{GS}=10V$) 19A $R_{DS(ON)}$ (at $V_{GS}=10V$) $< 85 m\Omega$ $R_{DS(ON)}$ (at V_{GS} =4.5V) $< 100 \text{m}\Omega$

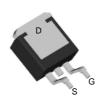
100% UIS Tested 100% R_g Tested

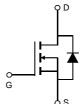


Bottom View Top View

TO-263







Absolute Maximum Ratings T_A=25℃ unless otherwise noted Parameter Symbol Maximum Units Drain-Source Voltage 150 V_{DS} Gate-Source Voltage ±20 V_{GS} T_C=25℃ 19 Continuous Drain I_D Current T_C=100℃ 13.5 Α Pulsed Drain Current 35 I_{DM} T_A=25℃ 3 Continuous Drain Α I_{DSM} T_A=70℃ 2.5 Current Avalanche Current C 9 Α I_{AS} Avalanche energy L=0.1mH ^C $\mathsf{E}_{\mathtt{AS}}$ 4 mJ T_C=25℃ 83 P_D W Power Dissipation ^B T_C=100℃ 41.5 T_A=25℃ 2.1 P_{DSM} W T_A=70℃ Power Dissipation A 1.3 Junction and Storage Temperature Range T_J, T_{STG} -55 to 175 \mathcal{C}

Thermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	12	15	℃/W				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	50	60	°C/W				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.5	1.8	℃/W				



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units			
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		150			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =150V, V _{GS} =0V				1	μΑ			
	Zero Gate Voltage Brain Gurrent		T _J =55℃			5	μΑ			
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.8	2.25	2.8	V			
I _{D(ON)}	On state drain current	V_{GS} =10V, V_{DS} =5V		35			Α			
R _{DS(ON)}		V_{GS} =10V, I_D =10A			70	85	mΩ			
	Static Drain-Source On-Resistance		T _J =125℃		139	170	11152			
		V_{GS} =4.5V, I_D =8A			78	100	mΩ			
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=10A$			35		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.72	1	V			
Is	Maximum Body-Diode Continuous Current					19	Α			
DYNAMIC	PARAMETERS									
C_{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =75V, f=1MHz			1165		pF			
Coss	Output Capacitance				61.5		pF			
C_{rss}	Reverse Transfer Capacitance				2.5		pF			
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		1.1	2.2	3.3	Ω			
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =75V, I _D =10A			15.5	22	nC			
Q _g (4.5V)	Total Gate Charge				7	10	nC			
Q_{gs}	Gate Source Charge				4		nC			
Q_{gd}	Gate Drain Charge				1.2		nC			
t _{D(on)}	Turn-On DelayTime				6.5		ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =75V, R_L =7.5 Ω , R_{GEN} =3 Ω			5		ns			
t _{D(off)}	Turn-Off DelayTime				23		ns			
t _f	Turn-Off Fall Time				2.5		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =10A, dI/dt=500A/μs			37		ns			
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =10A, dI/dt=500A/μs			265		nC			

A. The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150° $\,$ C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

 F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

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B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

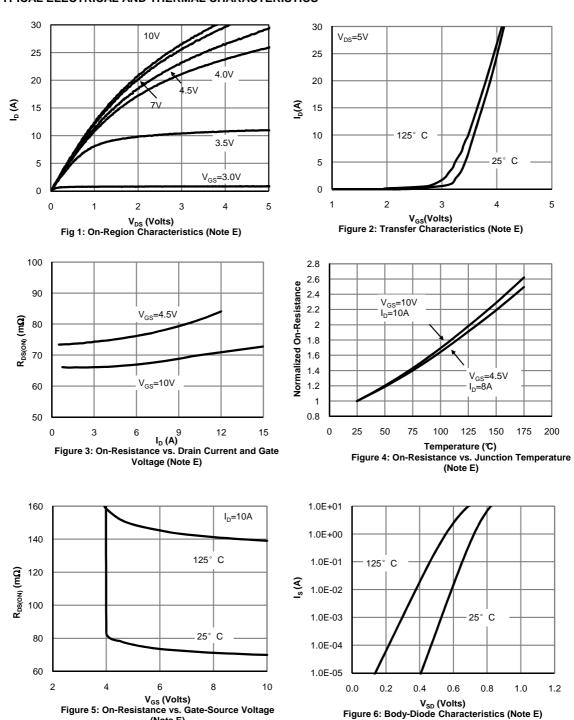
C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)



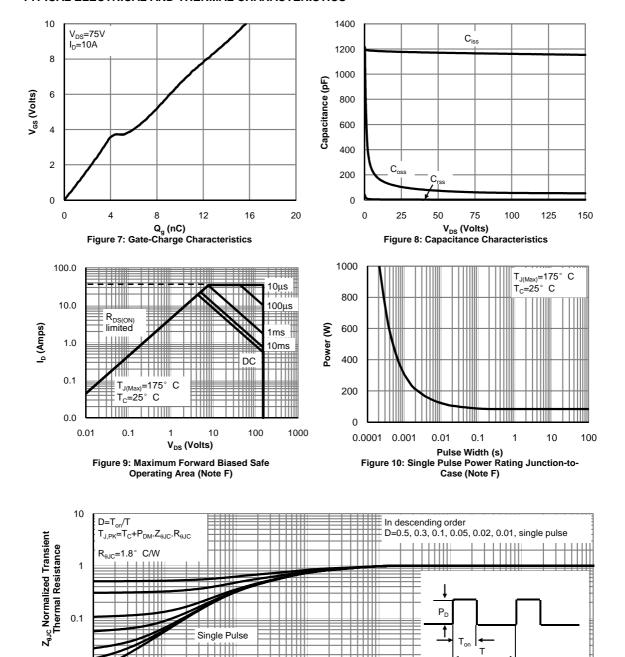


0.01 L

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

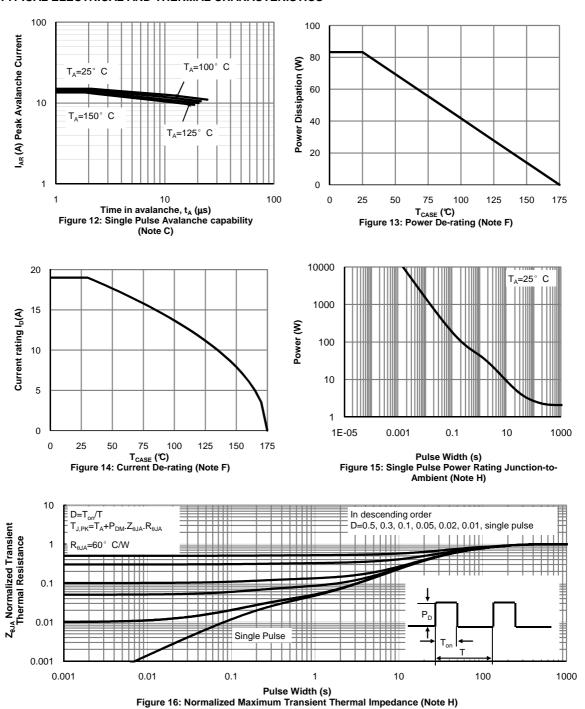
10

100

0.01

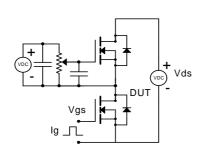


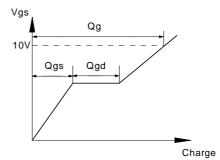
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



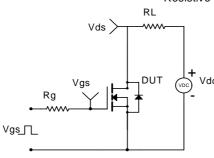


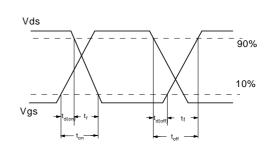
Gate Charge Test Circuit & Waveform



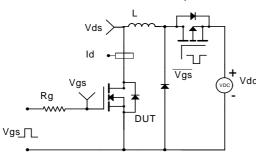


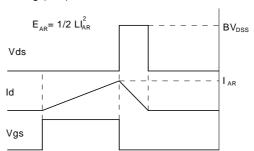
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

